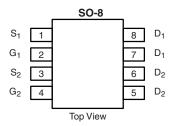




N- and P-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY								
	V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^a	Q _g (Typ.)				
N-Channel	30	$0.047 \text{ at V}_{GS} = 10 \text{ V}$	6.0	2.75				
IN-Charmer	30	0.065 at $V_{GS} = 4.5 \text{ V}$	5.2	2.75				
P-Channel	nel - 30	0.089 at $V_{GS} = -10 \text{ V}$	- 4.3	4.1				
r-Channel	- 30	0.140 at $V_{GS} = -4.5$ V	- 3.4	4.1				



Ordering Information: Si4532CDY-T1-GE3 (Lead (Pb)-free and Halogen-free)

FEATURES

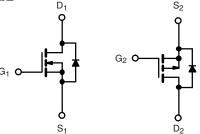
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % R_q Tested
- 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC



COMPLIANT HALOGEN **FREE**

APPLICATIONS

- DC/DC Conve
- Load Switch



N-Channel MOSFET

P-Channel MOSFET

Unit

ABSOLUTE MAXIMUM RATINGS	6 (T _A = 25 °C, unle	ess otherw	rise noted)	
Parameter	Symbol	N-Channel	P-Channel	
Drain-Source Voltage		V_{DS}	30	- 30
Gate-Source Voltage		V_{GS}	±	20
	T _C = 25 °C		6.0	- 4.3
Continuous Drain Current /T = 150 °C)	T _C = 70 °C		4.9	- 3.4
Continuous Drain Current (T _J = 150 °C)	T - 25 °C	'D	4 oh C	o th c

Diain Cource voltage	* DS	00	- 00	_ v	
Gate-Source Voltage		V _{GS}	±	20	V
	T _C = 25 °C		6.0	- 4.3	
Continuous Drain Current /T 150 °C)	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	4.9	- 3.4		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	'D	4.9 ^{b, c}	- 3.4 ^{b, c}	
	T _A = 70 °C		3.9 ^{b, c}	- 2.7 ^{b, c}	
Pulsed Drain Current (10 μs Pulse Width)		I _{DM}	24	- 15	Α
Course Dunin Courset Dinda Courset	T _C = 25 °C		2.3	- 2.3	
Source-Drain Current Diode Current	T _A = 25 °C	'S	1.5 ^{b, c}	- 1.5 ^{b, c}	
Pulsed Source-Drain Current		I _{SM}	24	- 12	
Single Pulse Avalanche Current	I = 0.1 mH	I _{AS}	7	8	
Single Pulse Avalanche Energy	L=0.11IIII	E _{AS}	2.5	3.2	mJ
	T _C = 25 °C		2.78	2.78	
Marian III David Discipation	T _C = 70 °C		1.78	1.78	w
Maximum Power Dissipation	T _A = 25 °C	FD F	1.78 ^{b, c}	1.78 ^{b, c}	
	T _A = 70 °C		1.14 ^{b, c}	- 4.3 - 3.4 - 3.4 ^{b, c} - 2.7 ^{b, c} - 15 - 2.3 - 1.5 ^{b, c} - 12 - 8 - 3.2 - 2.78 - 1.78	
Operating Junction and Storage Temperature R	T _J , T _{sta}	- 55 t	o 150	°C	

THERMAL RESISTANCE RATINGS									
		N-Ch	annel	P-Channel					
Parameter		Symbol	Тур.	Max.	Тур.	Max.	Unit		
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	57	70	57	70	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	37	45	37	45	O/VV		

Notes:

- a. Based on $T_C = 25$ °C.
- b. Surface mounted on 1" x 1" FR4 board.
- d. Maximum under steady state conditions is 120 °C/W (N-Channel) and 110 °C/W (P-Channel).



rameter Symbol Test Conditions			Min.	Typ. ^a	Max.	Unit		
Static							•	
Drain Source Brookdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	N-Ch	30			V	
Drain-Source Breakdown Voltage	V DS	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	P-Ch	- 30			V	
V Tomporatura Coefficient	AV /T	I _D = 250 μA	N-Ch		33		140	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA	P-Ch		- 33			
V Tananawatuwa Caaffiniant	AV /T	I _D = 250 μA	N-Ch		- 5.8		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	II _D = - 250 μA	P-Ch		4.5			
	.,	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	N-Ch	1.0		3.0	†	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = - 250 μA	P-Ch	- 1.0		- 3.0	V	
Oata Badal aslasas	1	V 0.V.V	N-Ch			100	^	
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	P-Ch			- 100	nA	
		V _{DS} = 30 V, V _{GS} = 0 V	N-Ch			1	1	
Zero Gate Voltage Drain Current		V _{DS} = - 30 V, V _{GS} = 0 V	P-Ch			- 1	1 .	
	I _{DSS}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$	N-Ch			5	μΑ	
		V _{DS} = - 30 V, V _{GS} = 0 V, T _J = 55 °C	P-Ch			- 5		
L	I _{D(on)}	$V_{DS} = 5 \text{ V}, V_{GS} = 10 \text{ V}$	N-Ch	20			А	
On-State Drain Current ^b		V _{DS} = - 5 V, V _{GS} = - 10 V	P-Ch	- 12				
	R _{DS(on)}	V _{GS} = 10 V, I _D = 3.5 A	N-Ch		0.038	0.047	†	
		V _{GS} = - 10 V, I _D = - 3.5 A	P-Ch		0.073	0.089	Ω	
Drain-Source On-State Resistance ^b		V _{GS} = 4.5 V, I _D = 2.8 A	N-Ch		0.052	0.065		
		V _{GS} = - 4.5 V, I _D = - 2.5 A	P-Ch		0.113	0.140		
	g _{fs}	V _{DS} = 15 V, I _D = 2.5 A	N-Ch		7	01110	_ s	
Forward Transconductance ^b		V _{DS} = - 15 V, I _D = - 3.5 A	P-Ch		7			
Dynamic ^a		103 10 1, 10 0.0 1						
Dynamic			N-Ch		305		1	
Input Capacitance	C _{iss}	N-Channel	P-Ch		340			
		$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	N-Ch		65			
Output Capacitance	C _{oss}	P-Channel	P-Ch		67		– pF –	
Reverse Transfer Capacitance	C _{rss}	V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz	N-Ch		29			
neverse fransier Capacitatice	Orss	26	P-Ch		51			
		$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 2.5 \text{ A}$	N-Ch		6	9		
Total Gate Charge	Q_g	$V_{DS} = -15 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -2.5 \text{ A}$	P-Ch		7.8	12		
Total date charge	~g		N-Ch		2.75	4.5		
		N-Channel $V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V} I_{D} = 2.5 \text{ A}$	P-Ch		4.1	6.2	nC	
Gate-Source Charge	Q _{gs}	10 v, v _{GS} = 7.5 v i _D = 2.5 A	N-Ch		1.3		_	
	⊶gs	P-Channel	P-Ch		1.3			
Gate-Drain Charge	Q_{gd}	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -2.5 \text{ A}$	N-Ch		0.9			
	9"		P-Ch		1.8	0.5		
Gate Resistance	R_{g}	H_{α} I $f = 1 \text{ MHz}$ I	N-Ch	0.6	3.1	6.2	Ω	
			P-Ch	2.0	10	20		



Parameter	Symbol	Test Conditions			Typ. ^a	Max.	Unit
Dynamic ^a							
Turn-On Delay Time	t _{d(on)}	N. Ohannad	N-Ch P-Ch		7	11	
Turn on Boldy Time	-u(on)	N-Channel $V_{DD} = 15 \text{ V, } R_L = 15 \Omega$			5.5	10	
Rise Time	t _r	$I_D \cong 1 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	N-Ch		12	18	1
	'		P-Ch		13	25	
Turn-Off Delay Time	t _{d(off)}	P-Channel			14	25	
	α(σ)	$V_{DD} = -15 \text{ V}, R_{L} = 15 \Omega$	P-Ch		17	30	
Fall Time	t _f	$I_D \cong -1 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$	N-Ch		6	10]
			P-Ch		7.7	15	ns
Turn-On Delay Time	t _{d(on)}	N-Channel	N-Ch		16	30	_
	, ,	$V_{DD} = 15 \text{ V}, R_L = 15 \Omega$	P-Ch N-Ch		40	60	
Rise Time	t _r	$I_D \cong 1 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_q = 1 \Omega$	_		16	30	
		-	P-Ch N-Ch		40 9	60 18	
Turn-Off Delay Time	t _{d(off)}	P-Channel _			20	40	
	t _f	V_{DD} = - 15 V, R_L = 15 Ω $I_D \cong$ - 1 A, V_{GEN} = - 4.5 V, R_g = 1 Ω	P-Ch N-Ch		9	18	
Fall Time			P-Ch		17	30	
Drain-Source Body Diode Characteris	stics		1 0		.,		
Continuous Source-Drain Diode		T 05.00	N-Ch			2.3	
Current	I _S	T _C = 25 °C	P-Ch			- 2.3	1
	I _{SM}		N-Ch			24	Α
Pulse Diode Forward Current ^a			P-Ch			- 12	1
B + B' + V''	.,	I _S = 1.25 A	N-Ch		0.8	1.2	V
Body Diode Voltage	V_{SD}	I _S = - 0.75 A	P-Ch		- 0.8	- 1.2	
Dadis Diada Dassarra Dassarra Tima			N-Ch		14	21	
Body Diode Reverse Recovery Time	t _{rr}		P-Ch		17	30	ns
Pady Diada Bayaraa Baaayary Charga	Q _{rr}	N-Channel I _F = 1.25 A, dl/dt = 100 A/μs, T _J = 25 °C	N-Ch		6	10	20
Body Diode Reverse Recovery Charge			P-Ch		11	20	nC
Reverse Recovery Fall Time	t _a	P-Channel	N-Ch		9		
Heverse necovery rail fille		$I_F = -2.5 \text{ A}, \text{ dI/dt} = -100 \text{ A/µs}, T_J = 25 °C$	P-Ch		12		ns
Reverse Recovery Rise Time	t _b		N-Ch		5		110
Tieverse riecovery riise Tillie	ъ		P-Ch		5		

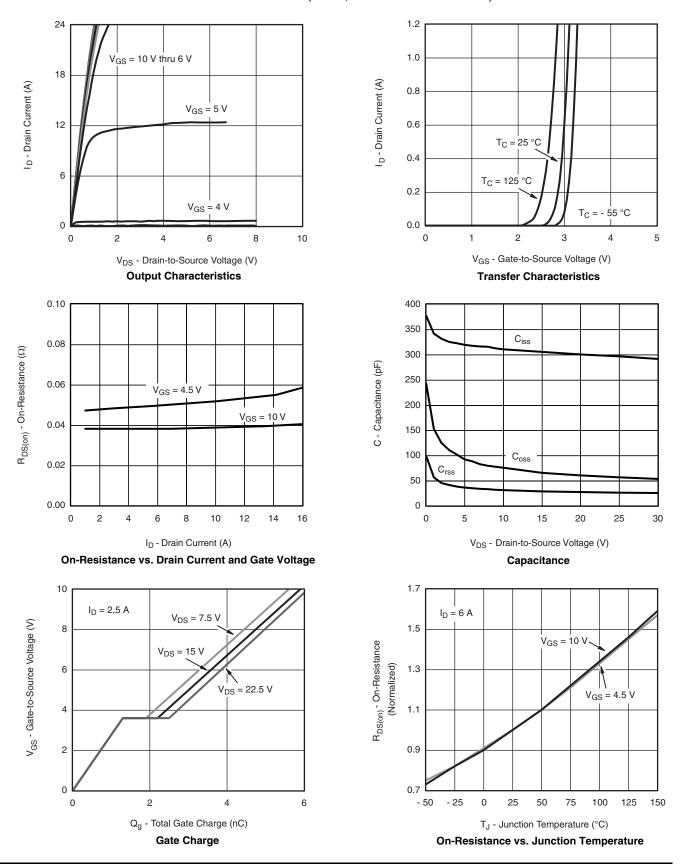
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Guaranteed by design, not subject to production testing.

b. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.

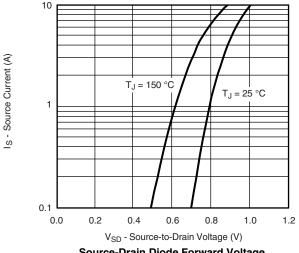


N-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

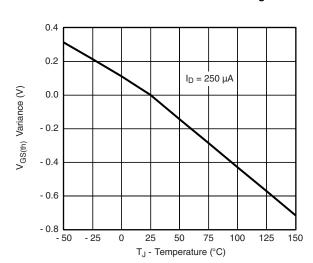




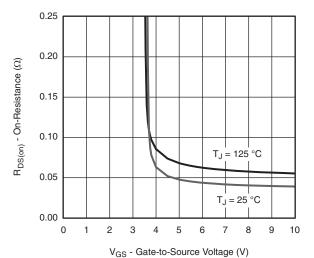
N-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



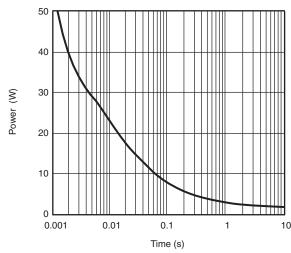




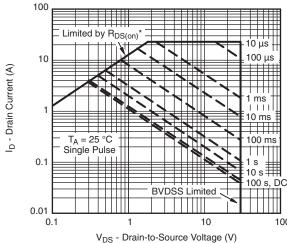
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

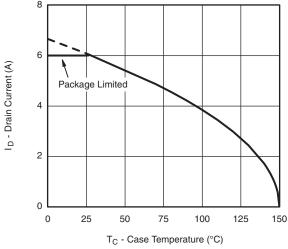


* $V_{GS} > \mbox{minimum } V_{GS}$ at which $R_{DS(on)}$ is specified

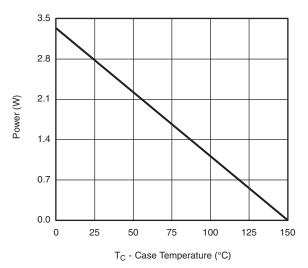
Safe Operating Area, Junction-to-Ambient



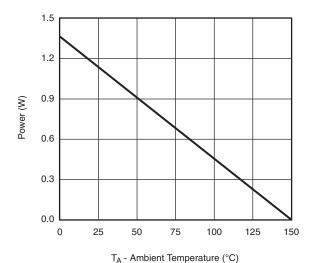
N-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating*





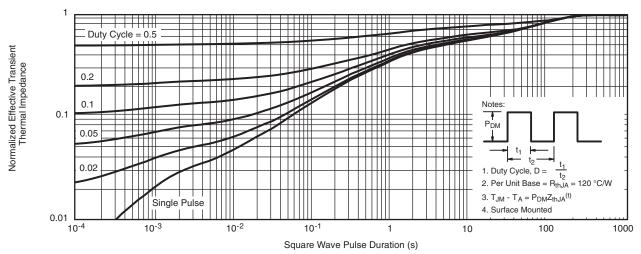


Power Derating, Junction-to-Ambient

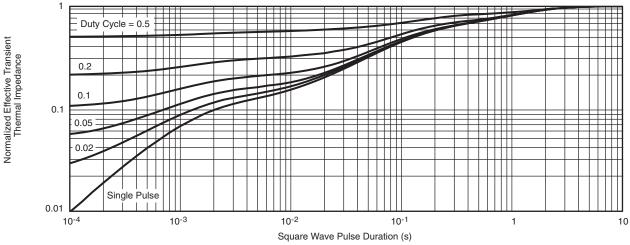
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



N-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



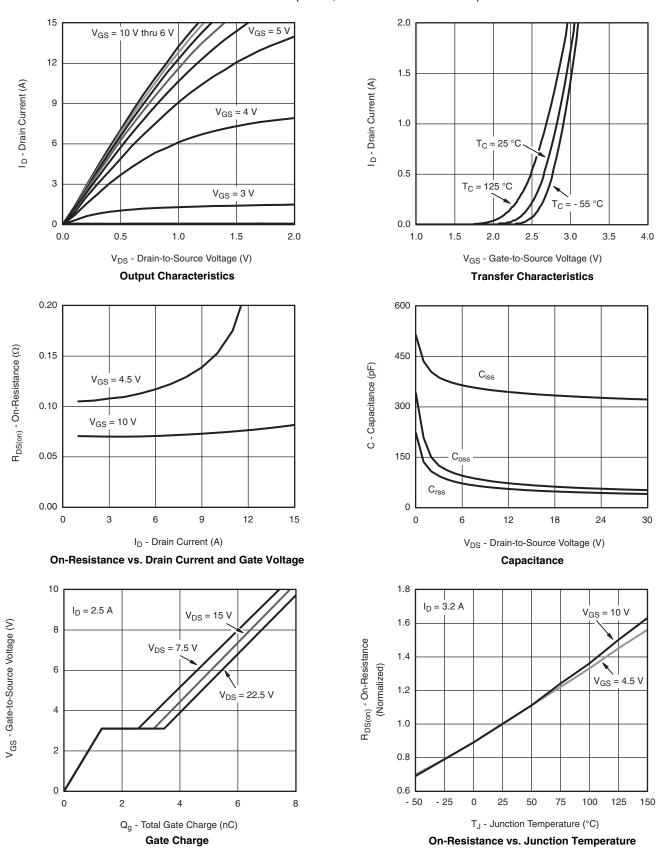
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

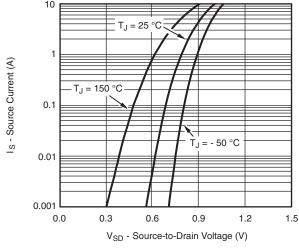


P-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

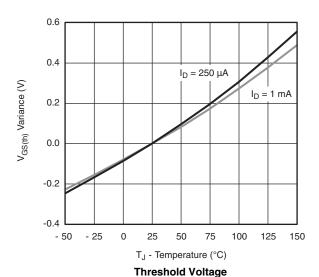


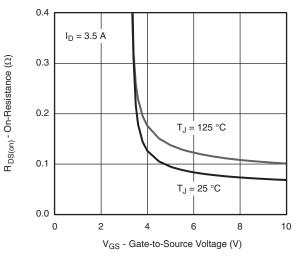


P-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

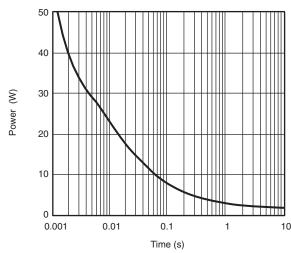


Source-Drain Diode Forward Voltage

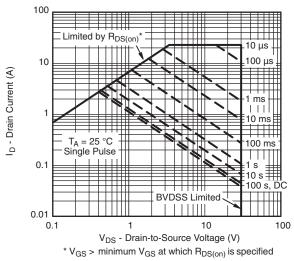




On-Resistance vs. Gate-to-Source Voltage



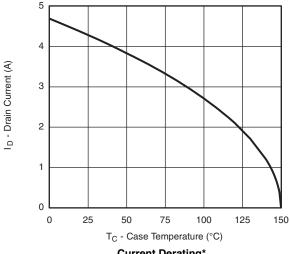
Single Pulse Power, Junction-to-Ambient



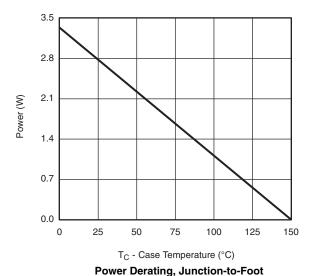
Safe Operating Area, Junction-to-Ambient

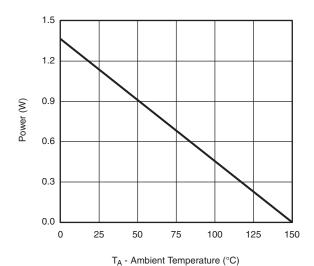


P-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating*



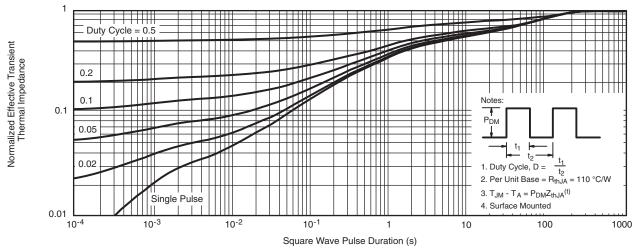


Power Derating, Junction-to-Ambient

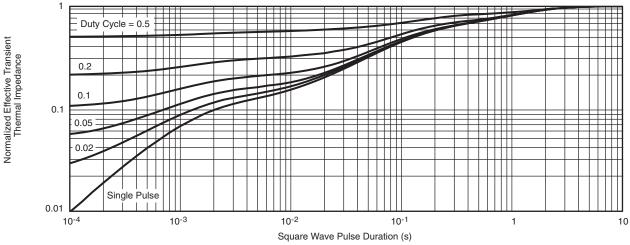
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heats inking is used. It is used to determine the current rating, when this rating falls below the package limit.



P-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIM	IETERS	INCHES				
DIM	Min	Max	Min	Max			
Α	1.35	1.75	0.053	0.069			
A ₁	0.10	0.20	0.004	0.008			
В	0.35	0.51	0.014	0.020			
С	0.19	0.25	0.0075	0.010			
D	4.80	5.00	0.189	0.196			
Е	3.80	4.00	0.150	0.157			
е	1.27	BSC	0.050 BSC				
Н	5.80	6.20	0.228	0.244			
h	0.25	0.50	0.010	0.020			
L	0.50	0.93	0.020	0.037			
q	0°	8°	0°	8°			
S	0.44	0.64	0.018	0.026			
ECN: C-06527-Rev. I. 11-Sep-06							

DWG: 5498

Document Number: 71192 www.vishay.com 11-Sep-06



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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